

PA-1DC

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>101065,523</u>	Prepared by <u>JS</u>	Tracking Number <u>5974701</u>	
Examiner-GAU <u>Fortuna-1723</u>	Date <u>7/12/04</u>	Week Date <u>7/15/04</u>	
	No. of queries <u>2</u>	Re-use IFW	

JACKET

a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
- h. Bracketing
- i. Missing Text
- j. Duplicate Text
- k. Other

MESSAGE

① Signature for Christina Trautmann is missing from the oath/declaration.

② PTO-1449: Please either initial or line-through citation(s). Copy provided for reference.

Thank you
initials JS

RESPONSE

initials

Based on Form PTO-1449 (3/90)				ATTY. DOCKET NO. 930008-2067		SERIAL NO. 10/085,523	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Zuzanna Siwy, et al.			
				FILING DATE February 26, 2002		GROUP TO BE ASSIGNED	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AA	3,770,532	11/6/73	Bean et al.	156	7		
AB							
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
AC	DE 38 16078 A1	5/11/88	Germany				X
AD	DE 42 10 486 C1	3/31/92	Germany				X
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
AE	P. Yu. Apel, et al., Morphology of Latent and Etched Heavy Ion Tracks in Radiation Resistant Polymers Polyimide and Poly(ethylene naphthalate), Nuclear Instruments and Methods in Physics Research B 185 (2001) pp. 216-221.						
AF	D. Bauer, et al., Relevance of Surface Gels for Ion Track Etching in Polymers, Gesellschaft für Schwerionenforschung, Planckstr. 1, D-64291 Darmstadt, Germany, Flerov Laboratory of Nuclear Reactions, JINR, 141980, Dubna, Russia, Imperial College, Hammersmith Campus, Du Cane Road, London W12 0NN, U.K., (2001) (one page).						
AG	A.L. Vilensky, et al. Polyimide Track Membranes for Ultrafiltration and Microfiltration, Polymer Science, Volume No. 36, No. 3, (1994) Birmingham, Alabama, PP. 391-400.						
AH	K. Schmidt-Rohr, Elucidation of the Chain Conformation in a Glassy Polyester, PET, by Two-Dimensional NMR, Science, Vol. 280, (May, 1998) pp. 714-717.						
AI	P. Apel, Track Etching Technique in Membrane Technology, Elsevier Science Ltd., Radiation Measurements 34 (2001) pp. 559-566.						
AJ	P. Yu. Apel, et al., Diode-like Single-Ion Track Membrane Prepared By Electro-Stopping, Nuclear Instruments and Methods in Physics Research, B 184 (2001) 337-346.						
AK	C. Trautmann, et al., Pore Geometry of Etched Ion Tracks in Polyimide, Nuclear Instruments and Methods in Physics Research B 111 (1996) pp. 70-47.						
AL	Lena Klintberg, et al., Sodium Hypochlorite as a Developer for Heavy Ion Tracks in Polyimide, Nuclear Instruments and Methods in Physics Research B 184 (2001) pp. 536-543.						
AM							
EXAMINER				DATE CONSIDERED			
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							